3.3V CMOS 20-BIT UNIVERSAL BUS DRIVER WITH 3-STATE OUTPUTS AND BUS-HOLD

IDT74ALVCH16836

FEATURES:

- 0.5 MICRON CMOS Technology
- Typical $t_{SK(o)}$ (Output Skew) < 250ps
- ESD > 2000V per MIL-STD-883, Method 3015; > 200V using machine model (C = 200pF, R = 0)
- V_{CC} = 3.3V ± 0.3V, Normal Range
- V_{CC} = 2.7V to 3.6V, Extended Range
- V_{CC} = 2.5V ± 0.2V
- CMOS power levels (0.4µ W typ. static)
- Rail-to-Rail output swing for increased noise margin
- Available in TSSOP package

DRIVE FEATURES:

- High Output Drivers: ±24mA
- Suitable for heavy loads

APPLICATIONS:

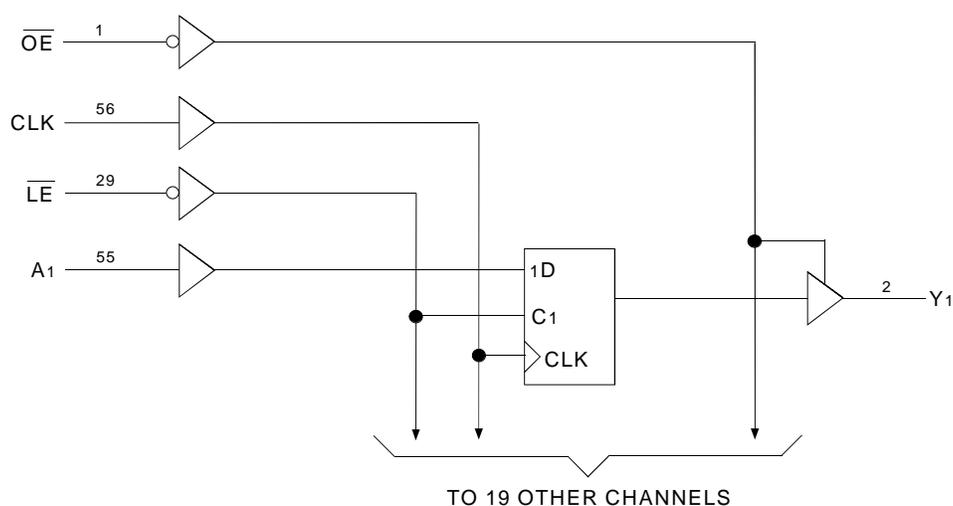- SDRAM Modules
- PC Motherboards
- Workstations

DESCRIPTION:

This 20-bit universal bus driver is built using advanced dual metal CMOS technology. Data flow from A to Y is controlled by the output-enable ($\overline{OE}$) input. The device operates in the transparent mode when the latch-enable ($\overline{LE}$) input is low. When $\overline{LE}$ is high, the A data is latched if the clock (CLK) input is held at a high or low logic level. If $\overline{LE}$ is high, the A data is stored in the latch/flip-flop on the low-to-high transition of CLK. When $\overline{OE}$ is high, the outputs are in the high-impedance state.
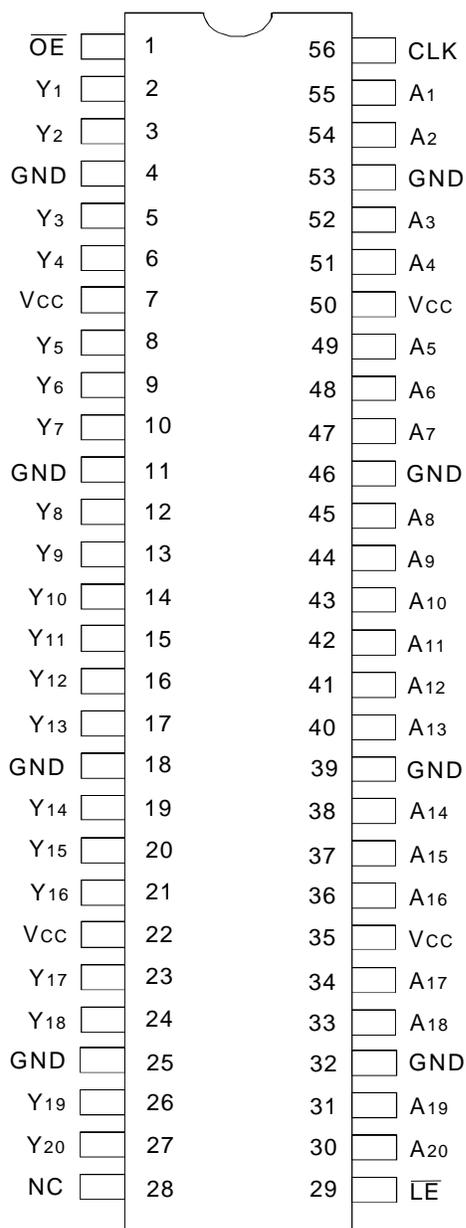
The ALVCH16836 has been designed with a ±24mA output driver. This driver is capable of driving a moderate to heavy load while maintaining speed performance.

The ALVCH16836 has "bus-hold" which retains the inputs' last state whenever the input bus goes to a high-impedance. This prevents floating inputs and eliminates the need for pull-up/down resistors.

FUNCTIONAL BLOCK DIAGRAM

TO 19 OTHER CHANNELS

INDUSTRIAL TEMPERATURE RANGE

JANUARY 2004

DSC-4498/3

PIN CONFIGURATION

$\overline{OE}$	1		56	CLK
Y_1	2		55	A_1
Y_2	3		54	A_2
GND	4		53	GND
Y_3	5		52	A_3
Y_4	6		51	A_4
V_{CC}	7		50	V_{CC}
Y_5	8		49	A_5
Y_6	9		48	A_6
Y_7	10		47	A_7
GND	11		46	GND
Y_8	12		45	A_8
Y_9	13		44	A_9
Y_{10}	14		43	A_{10}
Y_{11}	15		42	A_{11}
Y_{12}	16		41	A_{12}
Y_{13}	17		40	A_{13}
GND	18		39	GND
Y_{14}	19		38	A_{14}
Y_{15}	20		37	A_{15}
Y_{16}	21		36	A_{16}
V_{CC}	22		35	V_{CC}
Y_{17}	23		34	A_{17}
Y_{18}	24		33	A_{18}
GND	25		32	GND
Y_{19}	26		31	A_{19}
Y_{20}	27		30	A_{20}
NC	28		29	$\overline{LE}$

TSSOP
TOP VIEW

PIN DESCRIPTION

Pin Names	Description
$\overline{OE}$	3-State Output Enable Inputs (Active LOW)
CLK	Register Input Clock
$\overline{LE}$	Latch Enable (Active LOW)
A x	Data Inputs[1]
Y x	3-State Outputs
N C	No Internal Connection

NOTE:
1. These pins have "Bus-Hold". All other pins are standard inputs, outputs, or I/Os.

ABSOLUTE MAXIMUM RATINGS[1]

Symbol	Description	Max	Unit
V_{TERM}[2]	Terminal Voltage with Respect to GND	–0.5 to +4.6	V
V_{TERM}[3]	Terminal Voltage with Respect to GND	–0.5 to V_{CC}+0.5	V
T_{STG}	Storage Temperature	–65 to +150	°C
I_{OUT}	DC Output Current	–50 to +50	mA
I_{IK}	Continuous Clamp Current, V_I < 0 or V_I > V_{CC}	±50	mA
I_{OK}	Continuous Clamp Current, V_O < 0	–50	mA
I_{CC} I_{SS}	Continuous Current through each V_{CC} or GND	±100	mA

NOTES:
1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
2. V_{CC} terminals.
3. All terminals except V_{CC}.

CAPACITANCE (T_A = +25°C, F = 1.0MHz)

Symbol	Parameter[1]	Conditions	Typ.	Max.	Unit
C_{IN}	Input Capacitance	V_{IN} = 0V	5	7	pF
C_{OUT}	Output Capacitance	V_{OUT} = 0V	7	9	pF
C_{OUT}	I/O Port Capacitance	V_{IN} = 0V	7	9	pF

NOTE:
1. As applicable to the device type.

FUNCTION TABLE[1]

Inputs				Output
$\overline{OE}$	$\overline{LE}$	CLK	Ax	Yx
H	X	X	X	Z
L	L	X	L	L
L	L	X	H	H
L	H	↑	L	L
L	H	↑	H	H
L	H	H	X	Y[2]
L	H	L	X	Y[3]

NOTES:
1. H = HIGH Voltage Level
   L = LOW Voltage Level
   X = Don't Care
   ↑ = LOW-to-HIGH Transition
   Z = High-Impedance
2. Output level before the indicated steady-state input conditions were established, provided that CLK is HIGH before $\overline{LE}$ goes LOW.
3. Output level before the indicated steady-state input conditions were established.

DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:

Operating Condition: $T_A = -40°C$ to $+85°C$

Symbol	Parameter	Test Conditions		Min.	Typ.[1]	Max.	Unit
V_{IH}	Input HIGH Voltage Level	V_{CC} = 2.3V to 2.7V		1.7	—	—	V
		V_{CC} = 2.7V to 3.6V		2	—	—	
V_{IL}	Input LOW Voltage Level	V_{CC} = 2.3V to 2.7V		—	—	0.7	V
		V_{CC} = 2.7V to 3.6V		—	—	0.8	
I_{IH}	Input HIGH Current	V_{CC} = 3.6V	$V_I = V_{CC}$	—	—	±5	µA
I_{IL}	Input LOW Current	V_{CC} = 3.6V	V_I = GND	—	—	±5	µA
I_{OZH}	High Impedance Output Current	V_{CC} = 3.6V	$V_O = V_{CC}$	—	—	±10	µA
I_{OZL}	(3-State Output pins)		V_O = GND	—	—	±10	
V_{IK}	Clamp Diode Voltage	V_{CC} = 2.3V, I_{IN} = –18mA		—	–0.7	–1.2	V
V_H	Input Hysteresis	V_{CC} = 3.3V		—	100	—	mV
I_{CCL} I_{CCH} I_{CCZ}	Quiescent Power Supply Current	V_{CC} = 3.6V V_{IN} = GND or V_{CC}		—	0.1	40	µA
ΔI_{CC}	Quiescent Power Supply Current Variation	One input at V_{CC} - 0.6V, other inputs at V_{CC} or GND		—	—	750	µA

NOTE:

1. Typical values are at V_{CC} = 3.3V, +25°C ambient.

BUS-HOLD CHARACTERISTICS

Symbol	Parameter[1]	Test Conditions		Min.	Typ.[2]	Max.	Unit
I_{BHH}	Bus-Hold Input Sustain Current	V_{CC} = 3V	V_I = 2V	– 75	—	—	µA
I_{BHL}			V_I = 0.8V	75	—	—	
I_{BHH}	Bus-Hold Input Sustain Current	V_{CC} = 2.3V	V_I = 1.7V	– 45	—	—	µA
I_{BHL}			V_I = 0.7V	45	—	—	
I_{BHHO}	Bus-Hold Input Overdrive Current	V_{CC} = 3.6V	V_I = 0 to 3.6V	—	—	±500	µA
I_{BHLO}							

NOTES:

1. Pins with Bus-Hold are identified in the pin description.
2. Typical values are at V_{CC} = 3.3V, +25°C ambient.

OUTPUT DRIVE CHARACTERISTICS

Symbol	Parameter	Test Conditions[1]		Min.	Max.	Unit
V_{OH}	Output HIGH Voltage	V_{CC} = 2.3V to 3.6V	I_{OH} = – 0.1mA	V_{CC} – 0.2	—	V
		V_{CC} = 2.3V	I_{OH} = – 6mA	2	—	
		V_{CC} = 2.3V	I_{OH} = – 12mA	1.7	—	
		V_{CC} = 2.7V		2.2	—	
		V_{CC} = 3V		2.4	—	
		V_{CC} = 3V	I_{OH} = – 24mA	2	—	
V_{OL}	Output LOW Voltage	V_{CC} = 2.3V to 3.6V	I_{OL} = 0.1mA	—	0.2	V
		V_{CC} = 2.3V	I_{OL} = 6mA	—	0.4	
			I_{OL} = 12mA	—	0.7	
		V_{CC} = 2.7V	I_{OL} = 12mA	—	0.4	
		V_{CC} = 3V	I_{OL} = 24mA	—	0.55	

NOTE:

1. V_{IH} and V_{IL} must be within the min. or max. range shown in the DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE table for the appropriate V_{CC} range. T_A = – 40°C to + 85°C.

OPERATING CHARACTERISTICS, T_A = 25°C

Symbol	Parameter	Test Conditions	V_{CC} = 2.5V ± 0.2V Typical	V_{CC} = 3.3V ± 0.3V Typical	Unit
C_{PD}	Power Dissipation Capacitance Outputs enabled	C_L = 0pF, f = 10Mhz			pF
C_{PD}	Power Dissipation Capacitance Outputs disabled				

SWITCHING CHARACTERISTICS[1]

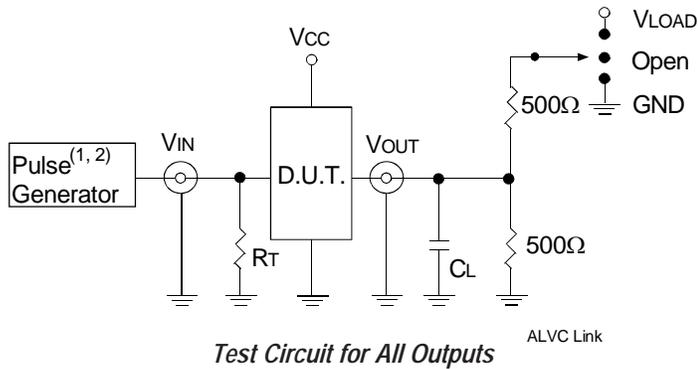| Symbol	Parameter	V_{CC} = 2.5V ± 0.2V		V_{CC} = 2.7V		V_{CC} = 3.3V ± 0.3V		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
f_{MAX}		150	—	150	—	150	—	ns
t_{PLH} t_{PHL}	Propagation Delay Ax to Yx	1	4.2	—	4.2	1	3.6	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{LE}$ to Yx	1.3	5	—	4.9	1.3	4.2	ns
t_{PLH} t_{PHL}	Propagation Delay CLK to Yx	1.4	5.5	—	5.2	1.4	4.5	ns
t_{PZH} t_{PZL}	Output Enable Time $\overline{OE}$ to Yx	1.4	5.5	—	5.6	1.1	4.6	ns
t_{PHZ} t_{PLZ}	Output Disable Time $\overline{OE}$ to Yx	1	4.5	—	4.3	1.3	3.9	ns
t_{SU}	Set-up Time, data before CLK↑	1.4	—	1.7	—	1.5	—	ns
t_{SU}	Set-up Time, data before $\overline{LE}$↑, CLK HIGH	1.2	—	1.6	—	1.3	—	ns
t_{SU}	Set-up Time, data before $\overline{LE}$↑, CLK LOW	1.4	—	1.5	—	1.2	—	ns
t_H	Hold Time, data after CLK↑	0.9	—	0.9	—	0.9	—	ns
t_H	Hold Time, data after $\overline{LE}$↑, CLK HIGH or LOW	1.1	—	1.1	—	1.1	—	ns
t_W	Pulse Duration, $\overline{LE}$ LOW	3.3	—	3.3	—	3.3	—	ns
t_W	Pulse Duration, CLK HIGH or LOW	3.3	—	3.3	—	3.3	—	ns
$t_{SK(O)}$	Output Skew[2]	—	—	—	—	—	500	ps

NOTES:
1. See TEST CIRCUITS AND WAVEFORMS. T_A = – 40°C to + 85°C.
2 Skew between any two outputs of the same package and switching in the same direction.

TEST CIRCUITS AND WAVEFORMS

TEST CONDITIONS

Symbol	$V_{CC}^{(1)}$ = 3.3V±0.3V	$V_{CC}^{(1)}$ = 2.7V	$V_{CC}^{(2)}$ = 2.5V±0.2V	Unit
V_{LOAD}	6	6	2 x V_{CC}	V
V_{IH}	2.7	2.7	V_{CC}	V
V_T	1.5	1.5	V_{CC} / 2	V
V_{LZ}	300	300	150	mV
V_{HZ}	300	300	150	mV
C_L	50	50	30	pF

Test Circuit for All Outputs

DEFINITIONS:

C_L = Load capacitance: includes jig and probe capacitance.

R_T = Termination resistance: should be equal to Z_{OUT} of the Pulse Generator.

NOTES:
1. Pulse Generator for All Pulses: Rate ≤ 1.0MHz; t_F ≤ 2.5ns; t_R ≤ 2.5ns.
2. Pulse Generator for All Pulses: Rate ≤ 1.0MHz; t_F ≤ 2ns; t_R ≤ 2ns.

SWITCH POSITION

Test	Switch
Open Drain Disable Low Enable Low	V_{LOAD}
Disable High Enable High	GND
All Other Tests	Open
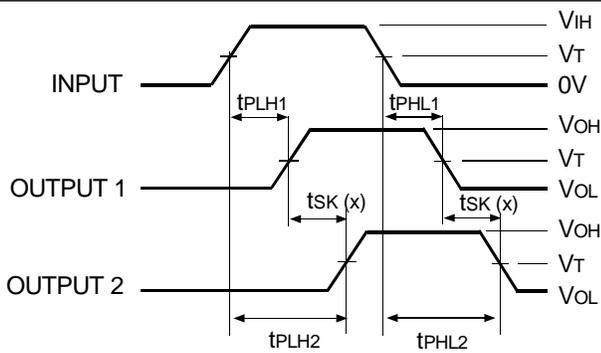
$$t_{SK}(x) = |t_{PLH2} - t_{PLH1}| \text{ or } |t_{PHL2} - t_{PHL1}|$$
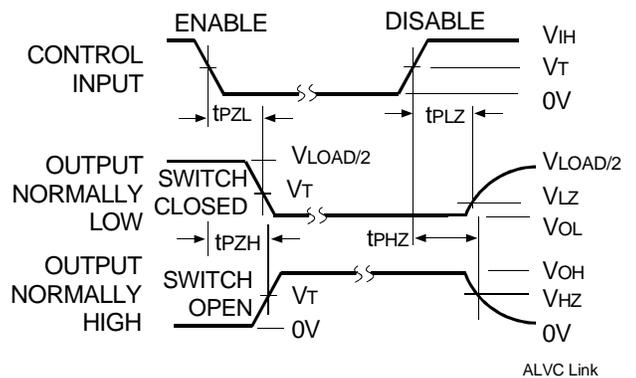
Output Skew - $t_{SK}(x)$

NOTES:
1. For $t_{SK}(o)$ OUTPUT1 and OUTPUT2 are any two outputs.
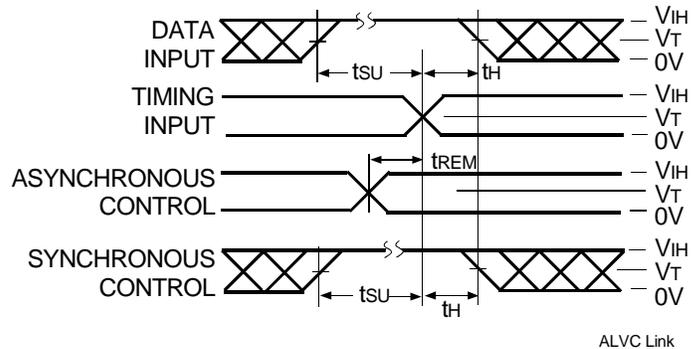2. For $t_{SK}(b)$ OUTPUT1 and OUTPUT2 are in the same bank.
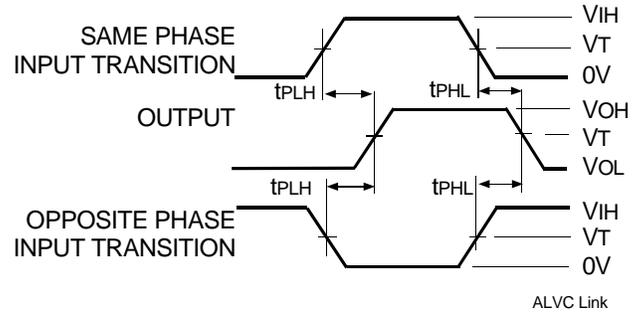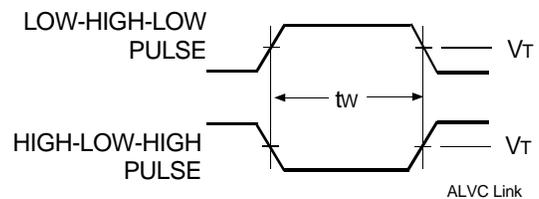

Propagation Delay

Enable and Disable Times

NOTE:
1. Diagram shown for input Control Enable-LOW and input Control Disable-HIGH.

Set-up, Hold, and Release Times

Pulse Width

ORDERING INFORMATION

IDT   XX   ALVC   X   XXX   XXX   XX

Temp. Range   Bus-Hold   Family   Device Type   Package

PA	Thin Shrink Small Outline Package
836	20-Bit Universal Bus Driver with 3-State Outputs
16	Double-Density, ±24mA
H	Bus-Hold
74	−40°C to +85°C